

BULD116D

MEDIUM VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- INTEGRATED ANTIPARALLEL COLLECTOR- EMITTER DIODE
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")

APPLICATIONS:

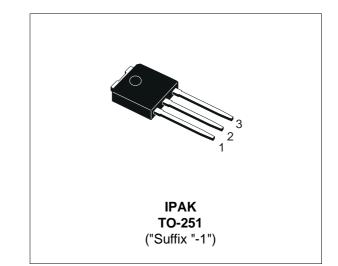
- COMPACT FLUORESCENT LAMPS UP TO 23 W AT 110 V A.C. MAINS
- FLYBACK AND FORWARD SINGLE TRANSISTOR LOW POWER CONVERTERS AT 110 V A.C. MAINS

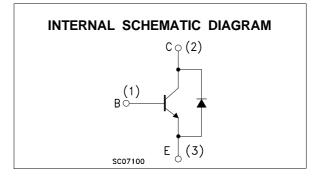
DESCRIPTION

The device is manufactured using Multi Epitaxial Planar technology for high switching speeds and medium voltage capability.

It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The device is designed for use in lighting applications and low cost switch-mode power supplies.





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
VCES	Collector-Emitter Voltage (V _{BE} = 0)	400	V
V _{CEO}	Collector-Emitter Voltage $(I_B = 0)$	200	V
V _{EBO}	Emitter-Base Voltage $(I_C = 0)$	9	V
Ι _C	Collector Current	5	А
Ісм	Collector Peak Current (t _p < 5 ms)	10	А
IB	Base Current	2	А
I _{BM}	Base Peak Current (t _p < 5 ms)	4	А
P _{tot}	Total Dissipation at $T_c = 25 \ ^{\circ}C$	20	W
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

THERMAL DATA

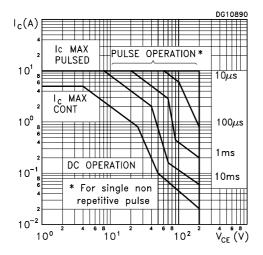
R _{thj-case}	Thermal Resistance Junction-Case	Мах	6.25	°C/W
R _{thj-amb}	Thermal Resistance Junction-Ambient	Max	100	°C/W

ELECTRICAL CHARACTERISTICS ($T_{case} = 25 \ ^{\circ}C$ unless otherwise specified)

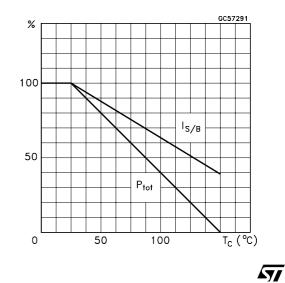
Symbol	Parameter	Test C	onditions	Min.	Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = 0)	V _{CE} = 400 V V _{CE} = 400 V	T _j = 125 °C			100 500	μΑ μΑ
V _{EBO}	Emitter-Base Voltage (I _C = 0)	I _E = 10 mA		9			V
$V_{CEO(sus)}^*$	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = 100 mA	L = 25 mH	200			V
ICEO	Collector-Emitter Leakage Current	V _{CE} = 200 V				250	μA
V _{CE(sat)} *	Collector-Emitter Saturation Voltage	I _C = 0.5 A I _C = 1 A I _C = 3 A I _C = 5 A	I _B = 50 mA I _B = 0.1 A I _B = 0.6 A I _B = 1 A			0.25 0.4 0.7 1.2	V V V V
$V_{BE(sat)^*}$	Base-Emitter Saturation Voltage	$I_{C} = 1 A$ $I_{C} = 5 A$	I _B = 0.1 A I _B = 1 A			1.1 1.5	V V
h _{FE} *	DC Current Gain	I _C = 10 mA I _C = 5 A	V _{CE} = 5 V V _{CE} = 5 V	10 8		20	
t _r t _f t _s	RESISTIVE LOAD Rise Time Fall Time Storage Time	$V_{CC} = 125 V$ $I_{B1} = 0.4 A$ $t_p = 30 \ \mu s$	$I_C = 2 A$ $I_{B2} = -0.4 A$ (see figure 2)		0.2 0.2 1.4	0.4	μs μs μs
t _s t _f	INDUCTIVE LOAD Storage Time Fall Time	$I_{C} = 2 A$ $V_{BE} = -5 V$ $V_{clamp} = 180 V$	I _{B1} = 0.4 A L = 500 μH (see figure 1)		0.5 0.10		μs μs
VF	Diode Forward Voltage	$I_{\rm C} = 2$ A				1.5	V

* Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

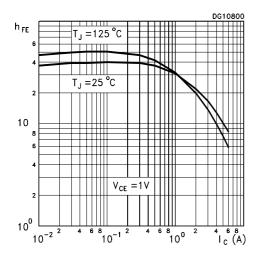
Safe Operating Area



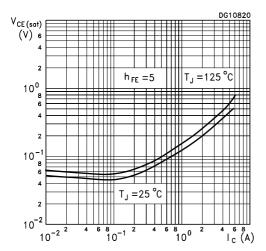
Derating Curve



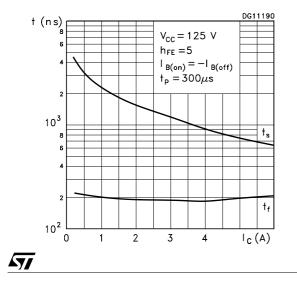
DC Current Gain



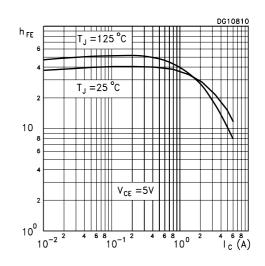
Collector-Emitter Saturation Voltage



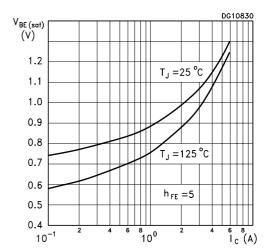
Switching Time Resistive Load



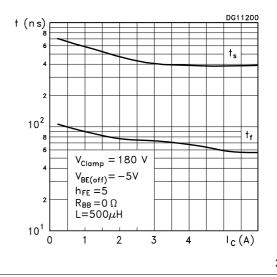
DC Current Gain



Base-Emitter Saturation Voltage



Switching Time Inductive Load



Reverse Biased SOA

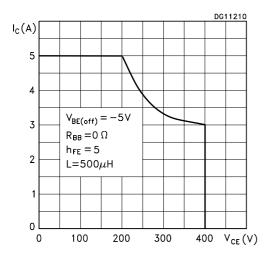


Figure 1: Inductive Load Switching Test Circuit.

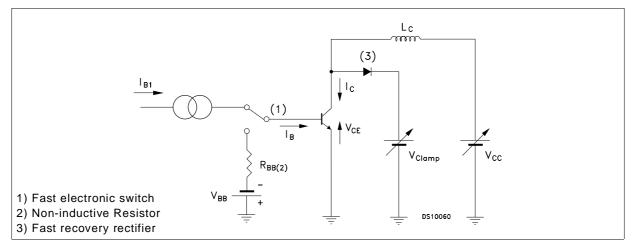
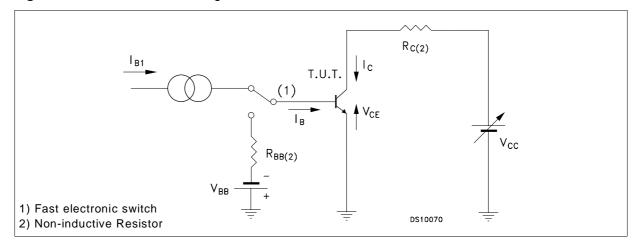


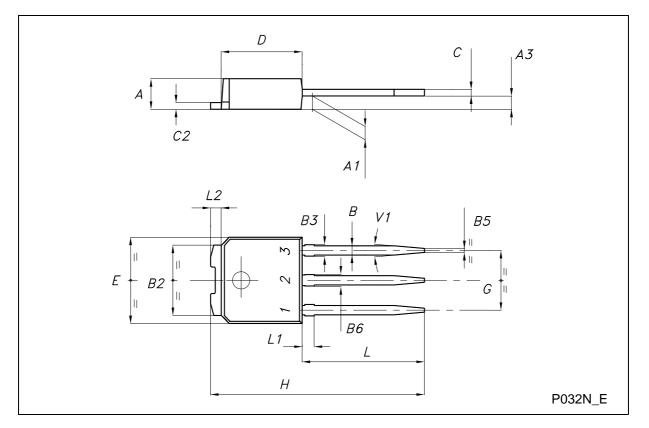
Figure 2: Resistive Load Switching Test Circuit.



57

DIM.	mm			inch			
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	2.20		2.40	0.087		0.094	
A1	0.90		1.10	0.035		0.043	
A3	0.70		1.30	0.028		0.051	
В	0.64		0.90	0.025		0.035	
B2	5.20		5.40	0.204		0.213	
B3			0.85			0.033	
B5		0.30			0.012		
B6			0.95			0.037	
С	0.45		0.60	0.018		0.024	
C2	0.48		0.60	0.019		0.024	
D	6.00		6.20	0.237		0.244	
Е	6.40		6.60	0.252		0.260	
G	4.40		4.60	0.173		0.181	
Н	15.90		16.30	0.626		0.642	
L	9.00		9.40	0.354		0.370	
L1	0.80		1.20	0.031		0.047	
L2		0.80	1.00		0.031	0.039	

TO-251 (IPAK) MECHANICAL DATA



5/6

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specification mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics. The ST logo is a trademark of STMicroelectronics.

All other names are the property of their respective owners.

© 2003 STMicroelectronics – All Rights reserved

STMicroelectronics GROUP OF COMPANIES

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States.

http://www.st.com

6/6

47/